FCC EMC TEST REPORT

ISSUED BY Shenzhen BALUN Technology Co., Ltd.

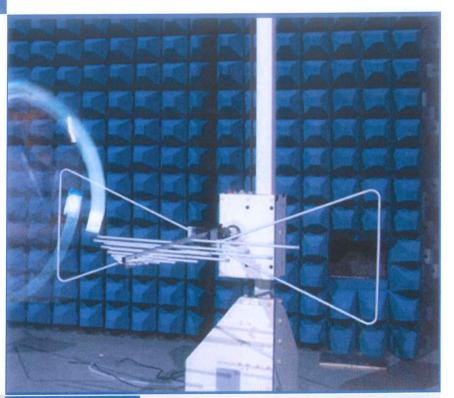


FOR

Mobile Phone

ISSUED TO
Shenzhen Sang Fei Consumer Communications Co., Ltd

11 Science and Technology Road, Shenzhen Hi-tech Industrial Park Nanshan District, Shenzhen city, GuangDong province, 518057, China



Tested by: Xia Long
Xia Long
(Engineer)
Date

Approved by:
Liao Jianming
(Technical Director)
Date

Two. Vb. Vol.)

Report No.:

BL-SZ1750142-401

EUT Name:

Mobile Phone

Model Name:

Philips S329

Brand Name:

PHILIPS

Test Standard:

47 CFR Part 15 Subpart B

FCC ID:

VQRCTS329

Test Conclusion:

Pass

Test Date:

May 10, 2017 ~ May 26, 2017

Date of Issue:

Jun. 26, 2017

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Revision History

Version Rev. 01

Issue Date Jun. 26, 2017 **Revisions Content**

Initial Issue

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1 GENERAL INFORMATION

1.1 Identification of the Testing Laboratory

Company Name	Shenzhen BALUN Technology Co., Ltd.
Addross	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi
Address	Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Identification of the Responsible Testing Location

Test Location	Shenzhen BALUN Technology Co., Ltd.
Addross	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi
Address	Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	The laboratory has been listed by Industry Canada to perform
	electromagnetic emission measurements. The recognition numbers
	of test site are 11524A-1.
A	The laboratory has been listed by US Federal Communications
Accreditation	Commission to perform electromagnetic emission measurements.
Certificate	The recognition numbers of test site are 832625.
	The laboratory is a testing organization accredited by China National
	Accreditation Service for Conformity Assessment (CNAS) according
	to ISO/IEC 17025. The accreditation certificate number is L6791.
	All measurement facilities used to collect the measurement data are
Description	located at Block B, FL 1, Baisha Science and Technology Park, Shahe
Description	Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R.
	China 518055

1.3 Laboratory Condition

Ambient Temperature	20°C~25°C
Ambient Relative Humidity	45% - 55%
Ambient Pressure	100 kPa - 102 kPa

1.4 Announce

- (1) The test report reference to the report template version v6.4.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- (5) This document may not be altered or revised in any way unless done so by BALUN and all revisions are duly noted in the revisions section.
- (6) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.



2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	Shenzhen Sang Fei Consumer Communications Co., Ltd
	11 Science and Technology Road, Shenzhen Hi-tech Industrial
Address	Park Nanshan District, Shenzhen city, GuangDong province,
	518057, China

2.2 Manufacturer Information

Manufacturer	Shenzhen Sang Fei Consumer Communications Co., Ltd
	11 Science and Technology Road, Shenzhen Hi-tech Industrial
Address	Park Nanshan District, Shenzhen city, GuangDong province,
	518057, China

2.3 Factory Information

Fa	actory	N/A
Ac	ddress	N/A

2.4 General Description for Equipment under Test (EUT)

EUT Name	Mobile Phone	
Model Name Under Test	Philips S329	
Series Model Name	N/A	
Description of Model	N/A	
name differentiation	147.	
Hardware Version	WMGEb	
Software Version	Philips_S329_1716_V01T02_AG	
Dimensions (Approx.)	N/A	
Weight (Approx.)	N/A	
	2G Network GSM/GPRS/EDGE 850/1900 MHz	
Network and Wireless	3G Network WCDMA/HSDPA/HSUPA Band 2/5	
connectivity	4G Network FDD LTE Band 4/5/7	
	Bluetooth, WIFI, GPS, FM	



2.5 Ancillary Equipment

	Battery		
	Brand Name	PHILIPS	
	Model No.	AB3000LWMT	
Ancillary Equipment 1	Serial No.	N/A	
	Capacitance	3000 mAh	
	Rated Voltage	3.85 V	
	Limit Charge Voltage	4.40 V	
	Adapter		
	Brand Name	PHILIPS	
Ancillary Equipment 2	Model No.	A88A-050100U-AR1	
Ancillary Equipment 2	Serial No.	N/A	
	Rated Input	100 - 240 V ~, 50/60 Hz, 0.2 A	
	Rated Output	5 V =, 1.0 A	
Ancillary Equipment 3	Earphone		
Andmary Equipment 3	Length (Approx.)	120 cm	
Ancillary Equipment 4	USB Cable		
Anomary Equipment 4	Length (Approx.)	80 cm	

2.6 Technical Information

Note: Not applicable.



3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	. Identity Document Title		
1	FCC 47 CFR Part 15	Unintentional Radiators	
ı	Subpart B (10-1-16 Edition)		
	ANSI C63.4-2014	American National Standard for Methods of	
		Measurement of Radio-Noise Emissions from Low-	
2		Voltage Electrical and Electronic Equipment in the	
		Range of 9 kHz to 40 GHz	

3.2 Verdict

No.	Description	FCC Rule	Test Verdict	Result
1	Radiated Emission	15.109	Pass	Annex A .1
2	Conducted Emission, AC Ports	15.107	Pass	Annex A .2

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	3.23 dB
Radiated emissions (30 MHz-1 GHz)	4.30 dB
Radiated emissions (1 GHz-18 GHz)	4.81 dB
Radiated emissions (18 GHz-40 GHz)	5.71 dB



4 GENERAL TEST CONFIGURATIONS

4.1 Test Environments

Environment	Selected Values During Tests					
Parameter	Temperature	Voltage	Relative Humidity	Ambient Pressure		
Normal Temperature,		AC 120 V/60 Hz				
Normal Voltage	23°C~26°C	or DC 3.85 V	50%-55%	100 to 102 kPa		
(NTNV)		from Battery				

4.2 Test Equipment List

	Radiated Emission Test								
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use			
EMI Receiver	KEYSIGHT	N9038A	MY53220118	2016.09.09	2017.09.08	\boxtimes			
EMI Receiver	ROHDE&SCHWARZ	ESRP	101036	2016.07.05	2017.07.04				
Test Antenna- Bi-Log	SCHWARZBECK	VULB 9163	9163-624	2015.07.22	2017.07.21	\boxtimes			
Test Antenna- Horn	SCHWARZBECK	BBHA 9120D	9120D-1148	2015.07.22	2017.07.21	\boxtimes			
Anechoic Chamber	RAINFORD	9m*6m*6m	N/A	2017.02.21	2019.02.20	\boxtimes			

	Conducted Emission Test								
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use			
EMI Receiver	ROHDE&SCHWARZ	ESRP	101036	2016.07.05	2017.07.04	\boxtimes			
LISN	SCHWARZBECK	NSLK 8127	8127-687	2016.07.05	2017.07.04	\boxtimes			
LISN	SCHWARZBECK	NNLK 8129	8129-462	2016.09.14	2017.09.13				
AMN	SCHWARZBECK	NNBM8124	8124-509	2016.07.05	2017.07.04				
AMN	SCHWARZBECK	NNBM8124	8124-510	2016.07.05	2017.07.04				
ISN	TESEQ	ISN T800	34449	2016.07.05	2017.07.04				
Shielded	ChangNing	CN-130701	130703	N/A	N/A	\boxtimes			
Enclosure	Changining	CIN-130701	130703	IN/A	IN/A				



4.3 Test Enclosure list

Description	Manufacturer	Model	Serial No.	Length	Description	Use
PC	Dell	015K3N	N/A	N/A	Special Handled	
Laptop	Apple	A1465	N/A	N/A	N/A	\boxtimes
Printer	HP	DESKJET 1000	N/A	N/A	N/A	
Keyboard	Logitech	Y-BP62a	N/A	N/A	N/A	
Mouse	Logitech	M100	N/A	N/A	N/A	
USB disk	Kingston	N/A	N/A	N/A	N/A	
TF Card	Kingston	N/A	N/A	N/A	N/A	\boxtimes
VGA Cable	N/A	N/A	N/A	1.5 m	Shielded with core	
HDMI Cable	N/A	N/A	N/A	1.5 m	Shielded with core	
DVI Cable	N/A	N/A	N/A	1.5 m	Shielded with core	
Coaxial video cable	N/A	N/A	N/A	2.0 m	Shielded with core	
iPhone	Apple	A1586	N/A	N/A	N/A	
Phone	MI	M4	N/A	N/A	N/A	
Bluetooth Earphone	SAMSUNG	Gear Circle	N/A	N/A	N/A	\boxtimes
GPS/GLONAS S Vector signal generator	R&S	N5172B EXG	N/A	N/A	N/A	\boxtimes
WIFI Router	TP-LINK	TL-WDR7500	N/A	N/A	N/A	\boxtimes
Earphone	N/A	OPPO	N/A	1.1 m	N/A	
Car Battery	Camel	55530	N/A	N/A	12 V/55 Ah	
Artificial load	N/A	N/A	N/A	N/A	2.5 Ω/100 W	
Artificial load	N/A	N/A	N/A	N/A	5 Ω/100 W	
Electronic Load	ITECH	IT8511	N/A	N/A	N/A	
USB Cable	N/A	N/A	N/A	1.5 m	Shielded with core	
DC Power Supply	ITECH	IT6863A	60001401068 7210006	N/A	N/A	
LCD Monitor	SAMSUNG	UA32C4000P	N/A	N/A	N/A	
LCD Monitor	Dell	U241HB	N/A	N/A	N/A	
RJ45 Cable	N/A	N/A	N/A	1.5 m	Shielded with core	



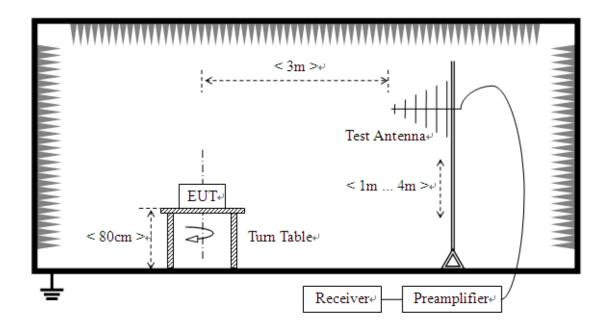
4.4 Test Configurations

Test							
Configurations	Description						
(TC) No.							
. ,	Traffic Test Mode						
	The GSM 850 MHz Test Mode						
TC01	GSM 850 Link + Adapter + USB Cable + Battery + TF Card + Earphone + BT Link +						
	WIFI Link + GPS RX						
	The EDGE 850 MHz Test Mode						
TC02	EDGE 850 Link + Adapter + USB Cable + Battery + TF Card + Earphone + BT Link +						
	WIFI Link + GPS RX						
	The GSM 1900 Test Mode						
TC03	GSM 1900 Link + Adapter + USB Cable + Battery + TF Card + Earphone + BT Link +						
	WIFI Link + GPS RX						
	The EDGE 1900 MHz Test Mode						
TC04	EDGE 1900 Link + Adapter + USB Cable + Battery + TF Card + Earphone + BT Link +						
	WIFI Link + GPS RX						
	The WCDMA Band 2 Test Mode						
TC05	WCDMA Band 2 + Adapter + USB Cable + Battery + TF Card + Earphone + BT Link +						
	WIFI Link + GPS RX						
	The WCDMA Band 5 test mode						
TC06	WCDMA Band 5 + Adapter + USB Cable + Battery + TF Card + Earphone + BT Link +						
	WIFI Link + GPS RX						
	The FDD LTE Band 4 Test Mode						
TC07	LTE Band 4 Link + Adapter + USB Cable + Battery + TF Card + Earphone + BT Link +						
	WIFI Link + GPS RX						
	The FDD LTE Band 5 Test Mode						
TC08	LTE Band 5 Link + Adapter + USB Cable + Battery + TF Card + Earphone + BT Link +						
	WIFI Link + GPS RX						
	The FDD LTE Band 7 Test Mode						
TC09	LTE Band 7 Link + Adapter + USB Cable + Battery + TF Card + Earphone + BT Link +						
	WIFI Link + GPS RX						
	The FDD LTE Band 28 Test Mode						
TC10	LTE Band 28 Link + Adapter + USB Cable + Battery + TF Card + Earphone + BT Link +						
	WIFI Link + GPS RX						
TC11	The Idle Test Mode						
	GSM 850(Idle) + Adapter + USB Cable + Battery + TF Card + Earphone + FM RX						
Amusement Tes							
TC12	The USB Test Mode						
	EUT + USB Cable + Battery + TF Card + Earphone + Laptop						
TC13	The Video Record Test Mode						
	EUT + Adapter + USB Cable + Battery + TF Card + Earphone						
TC14	The Video Play Test Mode						
	EUT + Adapter + USB Cable + Battery + TF Card + Earphone						



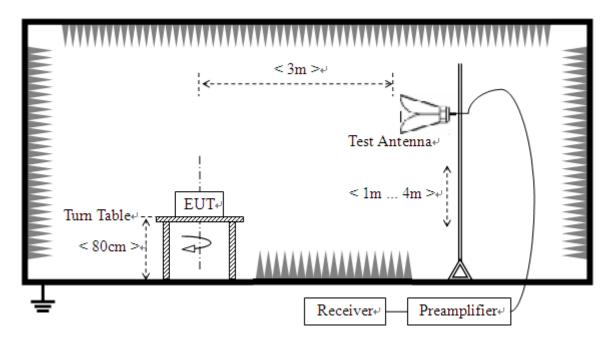
4.5 Test Setups

Test Setup 1



(For Radiated Emission Test (30 MHz-1 GHz))

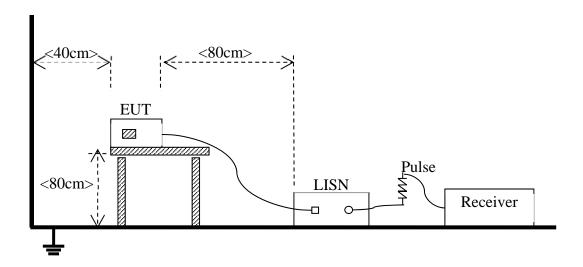
Test Setup 2



(For Radiated Emission Test (above 1 GHz))



Test Setup 3



(For Conducted Emission, AC Ports Test)



4.6 Test Conditions

Test Case	Test Conditions			
	Test Env.	NTNV		
Radiated Emission	Test Setup	Test Setup 1&2		
	Test Configuration	TC01~TC14 Note		
Conducted Emission AC	Test Env.	NTNV		
Conducted Emission, AC Ports	Test Setup	Test Setup 3		
	Test Configuration	TC01~TC14 Note		

Note: Based on client request, all normal using modes of the normal function were tested but only the worst test data of the worst mode is reported by this report. The GSM 850 MHz Test Mode is the worst mode in this report.



5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

Eroguenov renge	Class B	(at 3 m)	Class A (at 3 m)		
Frequency range (MHz)	Field Strength	Field Strength	Field Strength	Field Strength	
(IVITIZ)	(μV/m)	(dBµV/m)	(μV/m)	(dBµV/m)	
30 - 88	100	40	90	49	
88 - 216	150	43.5	150	53.5	
216 - 960	200	46	210	56.4	
Above 960	500	54	300	59.5	

NOTE:

- 1) Field Strength ($dB\mu V/m$) = 20*log [Field Strength ($\mu V/m$)].
- 2) In the emission tables above, the tighter limit applies at the band edges.

5.1.1.2 Test Setup

Refer to 4.5 section (test setup 1 to test setup 2) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

5.1.1.4 Test Result

Please refer to ANNEX A.1.



5.1.2 Conducted Emission

5.1.2.1 Test Limit

	Class A			
Frequency range (MHz)	Quasi-peak	Average		
	(dBµV)	(dBµV)		
0.15 - 0.50	79	66		
0.50 - 30	73	60		

	Class B			
Frequency range (MHz)	Quasi-peak	Average		
	(dBµV)	(dBµV)		
0.15 - 0.50	66 to 56	56 to 46		
0.50 - 5	56	46		
5 - 30	60	50		

NOTE:

- 1) The lower limit shall apply at the band edges.
- 2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50 MHz.

5.1.2.2 Test Setup

Refer to 4.5 section test (test setup 3) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The EUT is connected to the power mains through a LISN which provides $50 \Omega/50 \mu H$ of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

5.1.2.4 Test Result

Please refer to ANNEX A.2.



ANNEX A TEST RESULTS

A.1 Radiated Emission

Note 1: The symbol of "--" in the table which means not application.

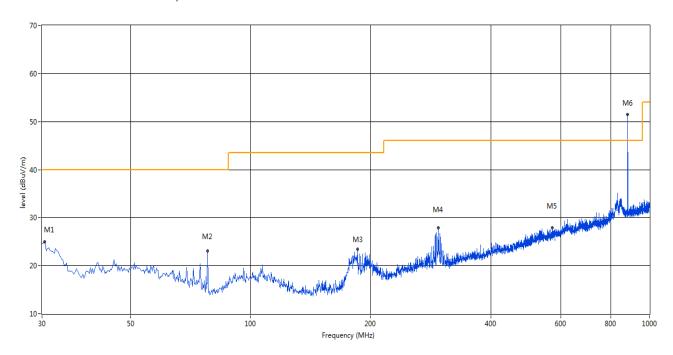
Note 2: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Note 3: This frequency which near 850 MHz with circle should be ignored because they are MS and SS carrier frequency, the marked spikes near 2400 MHz with circle should be ignored because they are Bluetooth or WIFI carrier frequency.

Test Data and Plots

The GSM 850 MHz Test Mode

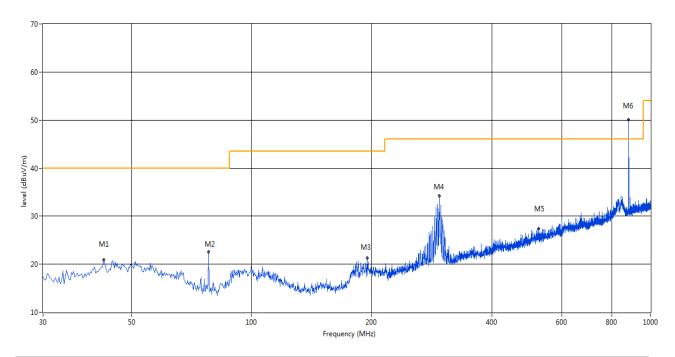
A.1.1 Test Antenna Vertical, 30 MHz – 1 GHz



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Table	Height	ANT	Verdict
	(MHz)	(dBuV/m)		(dBuV/m)	(dB)		(o)	(cm)		
1	30.485	25.01	-22.97	40.0	14.99	Peak	360.00	200	Vertical	Pass
2	78.015	23.09	-25.70	40.0	16.91	Peak	112.20	200	Vertical	Pass
3	185.200	23.51	-22.96	43.5	19.99	Peak	230.60	100	Vertical	Pass
4	295.538	27.83	-19.25	46.0	18.17	Peak	256.70	200	Vertical	Pass
5	569.805	27.94	-12.78	46.0	18.06	Peak	41.60	200	Vertical	Pass
6	881.660	51.53	-6.95	46.0	-5.53	Peak	0.00	100	Vertical	N/A



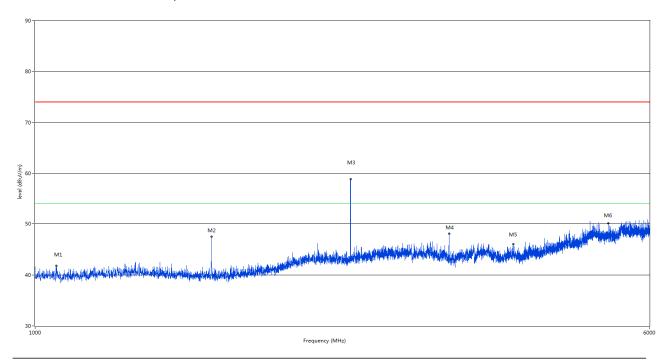
A.1.2 Test Antenna Horizontal, 30 MHz – 1 GHz



	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Table	Height	ANT	Verdict
	(MHz)	(dBuV/m)		(dBuV/m)	(dB)		(o)	(cm)		
1	42.610	20.96	-20.21	40.0	19.04	Peak	184.90	100	Horizontal	Pass
2	78.015	22.54	-25.70	40.0	17.46	Peak	360.00	300	Horizontal	Pass
3	194.658	21.31	-21.93	43.5	22.19	Peak	100.80	100	Horizontal	Pass
4	295.538	34.22	-19.25	46.0	11.78	Peak	81.10	100	Horizontal	Pass
5	523.730	27.40	-13.74	46.0	18.60	Peak	136.70	100	Horizontal	Pass
6	881.660	50.13	-6.95	46.0	-4.13	Peak	0.00	200	Horizontal	N/A



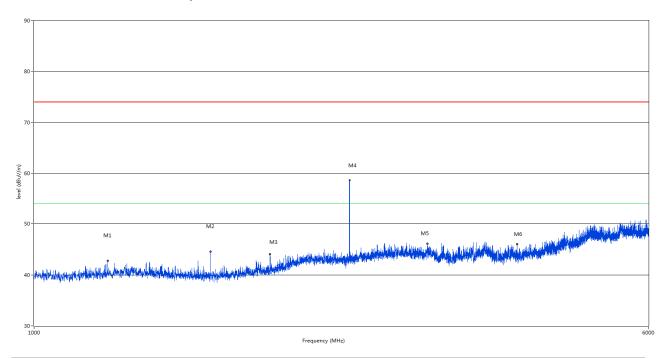
A.1.3 Test Antenna Vertical, 1 GHz – 6 GHz



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Table	Height	ANT	Verdict
	(MHz)	(dBuV/m)		(dBuV/m)	(dB)		(0)	(cm)		
1	1064.500	41.77	-7.25	74.0	32.23	Peak	127.90	100	Vertical	Pass
2	1673.000	47.48	-5.89	74.0	26.52	Peak	359.10	100	Vertical	N/A
3	2509.500	58.87	-2.40	74.0	15.13	Peak	359.10	100	Vertical	N/A
4	3345.750	48.03	5.97	74.0	25.97	Peak	328.90	100	Vertical	N/A
5	4032.000	45.99	8.81	74.0	28.01	Peak	0.00	100	Vertical	Pass
6	5317.500	50.15	11.18	74.0	23.85	Peak	4.80	100	Vertical	Pass



A.1.4 Test Antenna Horizontal, 1 GHz – 6 GHz



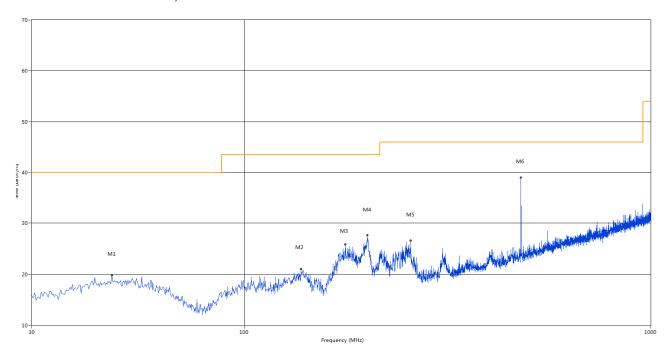
No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Table	Height	ANT	Verdict
	(MHz)	(dBuV/m)		(dBuV/m)	(dB)		(0)	(cm)		
1	1240.000	42.76	-6.64	74.0	31.24	Peak	170.30	100	Horizontal	Pass
2	1673.000	44.56	-5.89	74.0	29.44	Peak	257.20	100	Horizontal	N/A
3	1990.500	44.05	-4.54	74.0	29.95	Peak	292.20	100	Horizontal	Pass
4	2509.500	58.59	-2.40	74.0	15.41	Peak	8.40	100	Horizontal	N/A
5	3149.250	46.07	6.44	74.0	27.93	Peak	147.10	100	Horizontal	Pass
6	4089.750	46.05	8.42	74.0	27.95	Peak	244.70	100	Horizontal	Pass



Test Data and Plots

The USB Test Mode

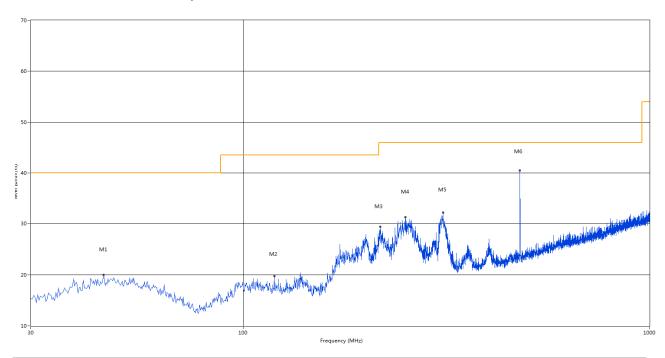
A.1.5 Test Antenna Vertical, 30 MHz – 1 GHz



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Table	Height	ANT	Verdict
	(MHz)	(dBuV/m)		(dBuV/m)	(dB)		(0)	(cm)		
1	47.218	19.78	-20.03	40.0	20.22	Peak	360.00	200	Vertical	Pass
2	137.913	21.03	-25.23	43.5	22.47	Peak	360.00	200	Vertical	Pass
3	177.440	25.88	-23.85	43.5	17.62	Peak	360.00	200	Vertical	Pass
4	200.962	27.64	-21.68	43.5	15.86	Peak	267.30	100	Vertical	Pass
5	256.980	26.63	-20.46	46.0	19.37	Peak	244.00	100	Vertical	Pass
6	480.080	39.05	-15.37	46.0	6.95	Peak	0.80	100	Vertical	Pass



A.1.6 Test Antenna Horizontal, 30 MHz – 1 GHz



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Table	Height	ANT	Verdict
	(MHz)	(dBuV/m)		(dBuV/m)	(dB)		(0)	(cm)		
1	45.278	19.96	-20.09	40.0	20.04	Peak	28.80	100	Horizontal	Pass
2	119.240	19.76	-23.30	43.5	23.74	Peak	220.60	100	Horizontal	Pass
3	217.210	29.39	-21.66	46.0	16.61	Peak	56.30	100	Horizontal	Pass
4	250.917	31.21	-20.60	46.0	14.79	Peak	47.20	100	Horizontal	Pass
5	310.573	32.14	-19.04	46.0	13.86	Peak	83.80	100	Horizontal	Pass
6	480.080	40.45	-15.37	46.0	5.55	Peak	250.00	100	Horizontal	Pass



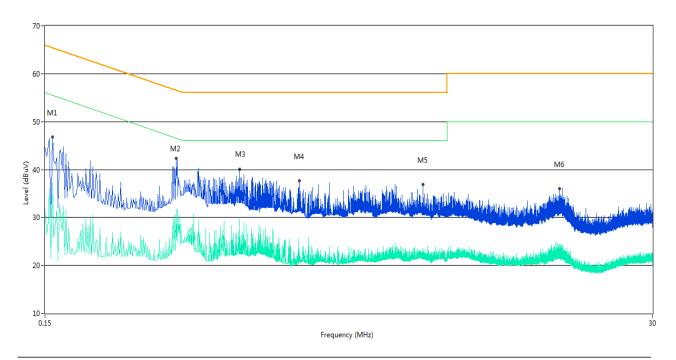
A.2 Conducted Emission

Note: Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. So, The configuration 120 VAC, 60 Hz and 240 VAC, 50 Hz were tested respectively, but only the worst configuration (120 VAC, 60 Hz) shown here.

Test Data and Plots

The GSM 850 MHz Test Mode

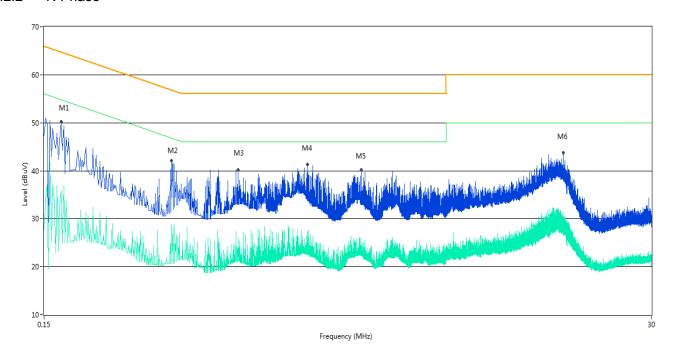
A.2.1 L Phase



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Line	Verdict
	(MHz)	(dBuV)		(dBuV)	(dB)			
1	0.160	46.8	10.29	65.5	18.70	Peak	L Line	Pass
1**	0.160	37.2	10.29	55.5	18.30	AV	L Line	Pass
2	0.470	42.4	10.33	56.5	14.10	Peak	L Line	Pass
2**	0.470	31.7	10.33	46.5	14.80	AV	L Line	Pass
3	0.818	40.1	10.32	56.0	15.90	Peak	L Line	Pass
3**	0.818	29.7	10.32	46.0	16.30	AV	L Line	Pass
4	1.378	37.7	9.94	56.0	18.30	Peak	L Line	Pass
4**	1.378	22.9	9.94	46.0	23.10	AV	L Line	Pass
5	4.048	36.8	10.17	56.0	19.20	Peak	L Line	Pass
5**	4.048	23.6	10.17	46.0	22.40	AV	L Line	Pass
6	13.308	36.0	11.26	60.0	24.00	Peak	L Line	Pass
6**	13.308	23.8	11.26	50.0	26.20	AV	L Line	Pass



A.2.2 N Phase



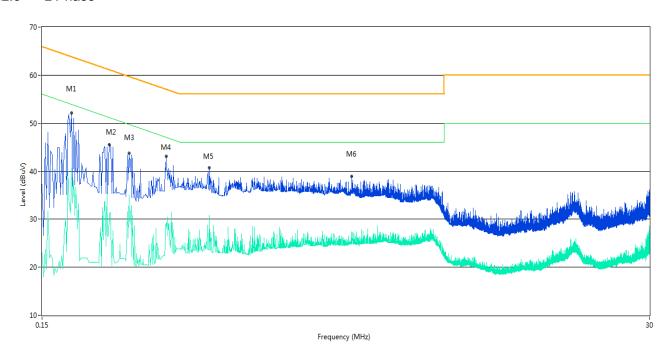
No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Line	Verdict
	(MHz)	(dBuV)		(dBuV)	(dB)			
1	0.174	50.2	9.53	64.8	14.60	Peak	N Line	Pass
1**	0.174	35.8	9.53	54.8	19.00	AV	N Line	Pass
2	0.456	42.1	9.14	56.8	14.70	Peak	N Line	Pass
2**	0.456	28.7	9.14	46.8	18.10	AV	N Line	Pass
3	0.814	40.2	10.04	56.0	15.80	Peak	N Line	Pass
3**	0.814	25.9	10.04	46.0	20.10	AV	N Line	Pass
4	1.490	41.4	10.30	56.0	14.60	Peak	N Line	Pass
4**	1.490	27.4	10.30	46.0	18.60	AV	N Line	Pass
5	2.384	40.2	10.59	56.0	15.80	Peak	N Line	Pass
5**	2.384	24.2	10.59	46.0	21.80	AV	N Line	Pass
6	13.878	43.8	11.30	60.0	16.20	Peak	N Line	Pass
6**	13.878	30.3	11.30	50.0	19.70	AV	N Line	Pass



Test Data and Plots

The USB Test Mode

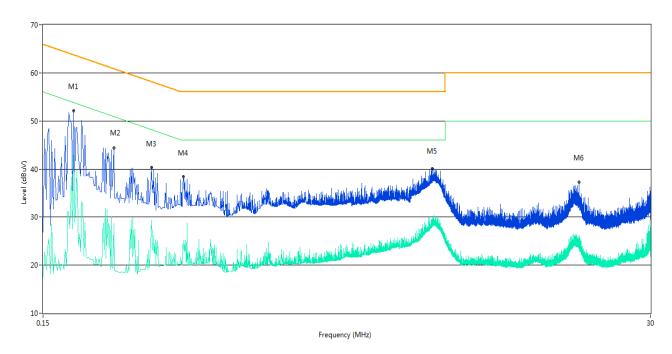
A.2.3 L Phase



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Line	Verdict
	(MHz)	(dBuV)		(dBuV)	(dB)			
1	0.194	52.1	9.43	63.9	11.80	Peak	L Line	Pass
1**	0.194	40.5	9.43	53.9	13.40	AV	L Line	Pass
2	0.270	45.5	10.32	61.1	15.60	Peak	L Line	Pass
2**	0.270	31.0	10.32	51.1	20.10	AV	L Line	Pass
3	0.320	43.7	10.13	59.7	16.00	Peak	L Line	Pass
3**	0.320	35.0	10.13	49.7	14.70	AV	L Line	Pass
4	0.444	43.1	10.51	57.0	13.90	Peak	L Line	Pass
4**	0.444	29.3	10.51	47.0	17.70	AV	L Line	Pass
5	0.646	40.7	10.69	56.0	15.30	Peak	L Line	Pass
5**	0.646	30.9	10.69	46.0	15.10	AV	L Line	Pass
6	2.232	38.9	10.64	56.0	17.10	Peak	L Line	Pass
6**	2.232	26.2	10.64	46.0	19.80	AV	L Line	Pass



A.2.4 N Phase



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Line	Verdict
	(MHz)	(dBuV)		(dBuV)	(dB)			
1	0.196	52.1	9.47	63.8	11.70	Peak	N Line	Pass
1**	0.196	42.9	9.47	53.8	10.90	AV	N Line	Pass
2	0.278	44.4	10.72	60.9	16.50	Peak	N Line	Pass
2**	0.278	28.7	10.72	50.9	22.20	AV	N Line	Pass
3	0.386	40.3	10.43	58.1	17.80	Peak	N Line	Pass
3**	0.386	29.4	10.43	48.1	18.70	AV	N Line	Pass
4	0.510	38.4	9.95	56.0	17.60	Peak	N Line	Pass
4**	0.510	23.4	9.95	46.0	22.60	AV	N Line	Pass
5	4.464	40.0	10.35	56.0	16.00	Peak	N Line	Pass
5**	4.464	29.9	10.35	46.0	16.10	AV	N Line	Pass
6	16.070	37.2	11.35	60.0	22.80	Peak	N Line	Pass
6**	16.070	26.2	11.35	50.0	23.80	AV	N Line	Pass



ANNEX B TEST SETUP PHOTOS

Please refer the document "BL-SZ1750142-AE.PDF".

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document "BL-SZ1750142-AW.PDF".

ANNEX D EUT INTERNAL PHOTOS

Please refer the document "BL-SZ1750142-AI.PDF".

--END OF REPORT--